

# Search Notes



Application/Control No.

10/658,190

Examiner

Yon Couso

Applicant(s)/Patent under  
Reexamination

ADACHI ET AL.

Art Unit

2624

## SEARCHED

Class	Subclass	Date	Examiner
382	232		
	233		
	236		
348	409	8-15-07 <i>cm</i>	
	415		
	439		
386	111		
	112		
	46		
	68		
	79		
	65		

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
PG Pat searched			
interference			
search included			
		8-15-07 <i>cm</i>	

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
East searched		
IEEE author		
searched	8-15-07 <i>cm</i>	
PALM inventor		
searched		